

**REVISIONS**

REV	DESCRIPTION	DATE (YR-MO-DA)	APPROVED
A	Technical changes in table I. Editorial changes throughout.	92-03-09	

REV																				
SHEET																				
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REV STATUS OF SHEETS	REV	A	A	A	A	A				A										
	SHEET	1	2	3	4	5	6	7	8											
PMIC N/A	PREPARED BY Monica L Poelking	DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO 45444																		
<b>STANDARDIZED MILITARY DRAWING</b>  THIS DRAWING IS AVAILABLE FOR USE BY ALL DEPARTMENTS AND AGENCIES OF THE DEPARTMENT OF DEFENSE  AMSC N/A	CHECKED BY Donald Cool	MICROCIRCUIT, DIGITAL, BIPOLAR, ADVANCED SCHOTTKY, TTL, HEX INVERTER, MONOLITHIC SILICON																		
	APPROVED BY Michael A Frye																			
	DRAWING APPROVAL DATE 89-01-18	SIZE A	CAGE CODE 67268	5962-88752																
	REVISION LEVEL A	SHEET	1	OF	8	1														

1. SCOPE

1.1 Scope. This drawing describes device requirements for class B microcircuits in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices".

1.2 Part or Identifying Number (PIN). The complete PIN shall be as shown in the following example:



1.2.1 Device type(s). The device type(s) shall identify the circuit function as follows:

<u>Device type</u>	<u>Generic number</u>	<u>Circuit function</u>
01	54F14	Hex inverter Schmitt trigger

1.2.2 Case outline(s). The case outline(s) shall be as designated in appendix C of MIL-M-38510, and as follows:

<u>Outline letter</u>	<u>Case outline</u>
C	D-1 (14-lead, .785" x .310" x .200"), dual-in-line package
D	F-2 (14-lead, .390" x .260" x .085"), flat package
2	C-2 (20-terminal, .358" x .358" x .100"), square chip carrier package

1.3 Absolute maximum ratings.

Supply voltage range <sup>1/</sup>	-0.5 V dc to +7.0 V dc
DC input voltage range	-0.5 V dc to +7.0 V dc
DC input current range	-30 mA to +5.0 mA
Voltage applied to output in high output state	-0.5 V dc to +V <sub>CC</sub>
Current applied to output in low output state	40 mA
Storage temperature range	-65°C to +150°C
Maximum power dissipation (P <sub>D</sub> ) <sup>2/</sup>	225 mW
Lead temperature (soldering, 10 seconds)	+260°C
Thermal resistance, junction-to-case (θ <sub>JC</sub> )	See MIL-M-38510, appendix C
Junction temperature (T <sub>J</sub> )	+175°C

1.4 Recommended operating conditions.

Supply voltage range (V <sub>CC</sub> )	4.5 V dc to 5.5 V dc
Maximum input clamp current (I <sub>IK</sub> )	-18 mA
Maximum high level output current (I <sub>OH</sub> )	-1.0 mA
Maximum low level output current (I <sub>OL</sub> )	20 mA
Case operating temperature range (T <sub>C</sub> )	-55°C to +125°C

<sup>1/</sup> Unless otherwise specified, all voltages are referenced to ground.

<sup>2/</sup> Must withstand the added P<sub>D</sub> due to the short circuit output current test; eg., I<sub>OS</sub>.

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2. APPLICABLE DOCUMENTS  
 查询"5962-88752012A" 供应商

2.1 Government specification, standard, and bulletin. Unless otherwise specified, the following specification, standard, and bulletin of the issue listed in that issue of the Department of Defense Index of Specifications and Standards specified in the solicitation, form a part of this drawing to the extent specified herein.

SPECIFICATION

MILITARY

MIL-M-38510 - Microcircuits, General Specification for.

STANDARD

MILITARY

MIL-STD-883 - Test Methods and Procedures for Microelectronics.

BULLETIN

MILITARY

MIL-BUL-103 - List of Standardized Military Drawings (SMD's).

(Copies of the specification, standard, and bulletin required by manufacturers in connection with specific acquisition functions should be obtained from the contracting activity or as directed by the contracting activity.)

2.2 Order of precedence. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing shall take precedence.

3. REQUIREMENTS

3.1 Item requirements. The individual item requirements shall be in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices" and as specified herein.

3.2 Design, construction, and physical dimensions. The design, construction, and physical dimensions shall be as specified in MIL-M-38510 and herein.

3.2.1 Case outline(s). The case outline(s) shall be in accordance with 1.2.2 herein.

3.2.2 Terminal connections. The terminal connections shall be as specified on figure 1.

3.2.3 Truth table. The truth table shall be as specified on figure 2.

3.2.4 Test circuit and switching waveforms. The test circuit and switching waveforms shall be as specified on figure 3.

3.3 Electrical performance characteristics. Unless otherwise specified herein, the electrical performance characteristics are as specified in table I and shall apply over the full case operating temperature range.

3.4 Electrical test requirements. The electrical test requirements shall be the subgroups specified in table II. The electrical tests for each subgroup are described in table I.

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TABLE I. Electrical performance characteristics.

Test	Symbol	Conditions -55°C ≤ T <sub>c</sub> ≤ +125°C unless otherwise specified	Group A subgroups	Limits		Unit	
				Min	Max		
Positive going threshold voltage	V <sub>T+</sub>	V <sub>CC</sub> = 5.0 V 1/	1, 2, 3	1.4	2.0	V	
Negative going threshold voltage	V <sub>T-</sub>	V <sub>CC</sub> = 5.0 V 1/	1, 2, 3	0.7	1.1	V	
Hysteresis (V <sub>T+</sub> - V <sub>T-</sub> )	ΔV <sub>T</sub>	V <sub>CC</sub> = 5.0 V 2/	1, 2, 3	0.4		V	
High level output voltage	V <sub>OH</sub>	V <sub>CC</sub> = 4.5 V, V <sub>IN</sub> = 0.7 V, I <sub>OH</sub> = -1.0 mA	1, 2, 3	2.5		V	
Low level output voltage	V <sub>OL</sub>	V <sub>CC</sub> = 4.5 V, V <sub>IN</sub> = 2.0 V, I <sub>OL</sub> = 20 mA	1, 2, 3		0.5	V	
Input clamp voltage	V <sub>IK</sub>	V <sub>CC</sub> = 4.5 V, I <sub>IK</sub> = -18 mA	1		-1.2	V	
High level input current	I <sub>IH1</sub>	V <sub>CC</sub> = 5.5 V, V <sub>IN</sub> = 2.7 V	1, 2, 3		20	μA	
Input current at maximum input voltage	I <sub>IH2</sub>	V <sub>CC</sub> = 5.5 V, V <sub>IN</sub> = 7.0 V	1, 2, 3		100	μA	
Low level input current	I <sub>IL</sub>	V <sub>CC</sub> = 5.5 V, V <sub>IN</sub> = 0.5 V	1, 2, 3		-0.6	mA	
Short circuit output current	I <sub>OS</sub>	V <sub>CC</sub> = 5.5 V 3/	1, 2, 3	-60	-150	mA	
Supply current (total)	I <sub>CCH</sub>	V <sub>CC</sub> = 5.5 V	V <sub>IN</sub> = GND	1, 2, 3	25	mA	
	I <sub>CCL</sub>						V <sub>IN</sub> = 4.5 V
Functional tests		See 4.3.1c, V <sub>CC</sub> = 4.5 V, 5.5 V	7, 8				
Propagation delay time, A to Y	t <sub>PLH</sub>	R <sub>L</sub> = 500Ω C <sub>L</sub> = 50 pF See figure 3	V <sub>CC</sub> = 5.0 V	9	2.5	11	ns
			V <sub>CC</sub> = 4.5 V and 5.5 V	10, 11	2.0	13	
	V <sub>CC</sub> = 5.0 V		9	3.5	8		
	V <sub>CC</sub> = 4.5 V and 5.5 V		10, 11	3.0	10		

1/ Test not required if used as a forcing function for V<sub>OL</sub> or V<sub>OH</sub>.  
 2/ If not tested, the limits shall be guaranteed to the limits specified in table I.  
 3/ Not more than one output should be shorted at one time and the duration of the short circuit condition shall not exceed 1 second.

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3.5 Marking. Marking shall be in accordance with MIL-STD-883 (see 3.1 herein). The part shall be marked with the PIN listed in 1.2 herein. In addition, the manufacturer's PIN may also be marked as listed in MIL-BUL-103 (see 6.6 herein).

3.6 Certificate of compliance. A certificate of compliance shall be required from a manufacturer in order to be listed as an approved source of supply in MIL-BUL-103 (see 6.6 herein). The certificate of compliance submitted to DESC-ECC prior to listing as an approved source of supply shall affirm that the manufacturer's product meets the requirements of MIL-STD-883 (see 3.1 herein) and the requirements herein.

3.7 Certificate of conformance. A certificate of conformance as required in MIL-STD-883 (see 3.1 herein) shall be provided with each lot of microcircuits delivered to this drawing.

3.8 Notification of change. Notification of change to DESC-ECC shall be required in accordance with MIL-STD-883 (see 3.1 herein).

3.9 Verification and review. DESC, DESC's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.

#### 4. QUALITY ASSURANCE PROVISIONS

4.1 Sampling and inspection. Sampling and inspection procedures shall be in accordance with section 4 of MIL-M-38510 to the extent specified in MIL-STD-883 (see 3.1 herein).

4.2 Screening. Screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection. The following additional criteria shall apply:

a. Burn-in test, method 1015 of MIL-STD-883.

(1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.6 herein).

(2)  $T_A = +125^\circ\text{C}$ , minimum.

b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.

4.3 Quality conformance inspection. Quality conformance inspection shall be in accordance with method 5005 of MIL-STD-883 including groups A, B, C, and D inspections. The following additional criteria shall apply.

##### 4.3.1 Group A inspection.

a. Tests shall be as specified in table II herein.

b. Subgroups 4, 5, and 6 in table I, method 5005 of MIL-STD-883 shall be omitted.

c. Subgroups 7 and 8 shall include verification of the truth table.

##### 4.3.2 Groups C and D inspections.

a. End-point electrical parameters shall be as specified in table II herein.

b. Steady-state life test conditions, method 1005 of MIL-STD-883.

(1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.6 herein).

(2)  $T_A = +125^\circ\text{C}$ , minimum.

(3) Test duration: 1,000 hours, except as permitted by method 1005 of MIL-STD-883.

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Device type	01	
Case outlines	C and D	2
Terminal number	Terminal symbol	
1	A1	NC
2	Y1	A1
3	A2	Y1
4	Y2	A2
5	A3	NC
6	Y3	Y2
7	GND	NC
8	Y4	A3
9	A4	Y3
10	Y5	GND
11	A5	NC
12	Y6	Y4
13	A6	A4
14	V <sub>CC</sub>	Y5
15	---	NC
16	---	A5
17	---	NC
18	---	Y6
19	---	A6
20	---	V <sub>CC</sub>

NC = No connection

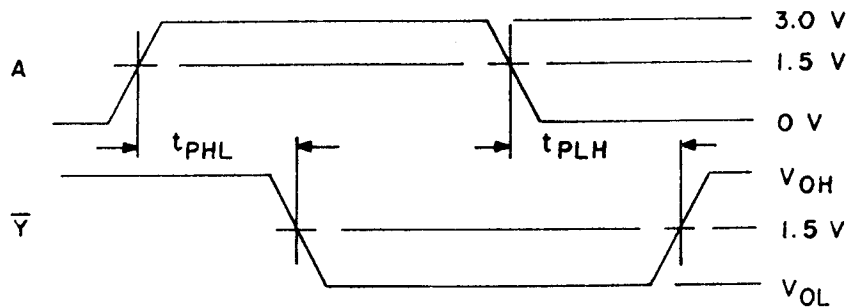
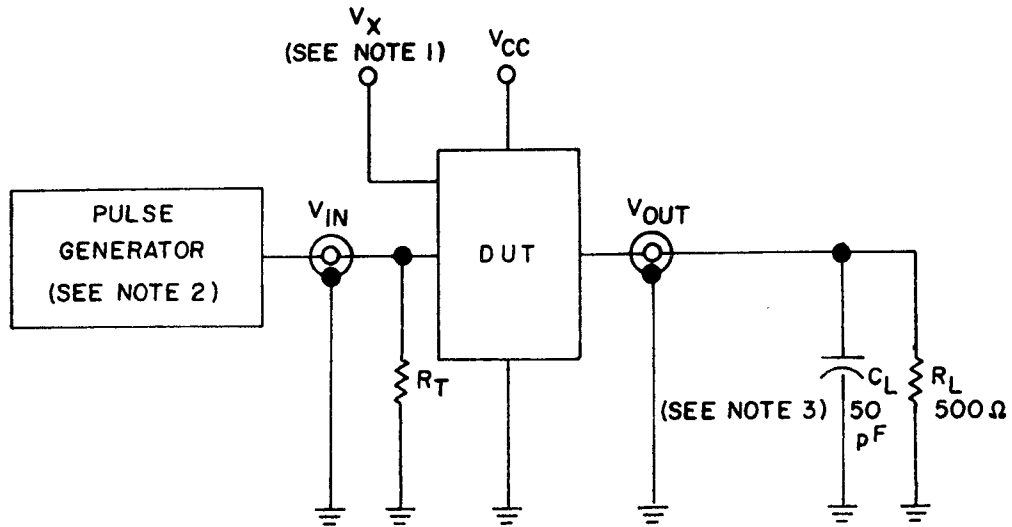
FIGURE 1. Terminal connections.

Input	Output
A	$\bar{Y}$
L	H
H	L

H = High voltage level  
L = Low voltage level

FIGURE 2. Truth table.

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NOTES:

1.  $V_X$  = Unlocked pins must be held at  $\leq 0.8$  V,  $\geq 2.7$  V, or open.  
 $R_T$  = Termination resistance; should be equal to  $Z_{OUT}$  of the pulse generator.
2. All input pulses have the following characteristics:  
 PRR = 1.0 MHz, pulse width = 500 ns, duty cycle = 50%,  $t_r = t_f \leq 2.5$  ns.
3.  $C_L$  includes jig and probe capacitance.

FIGURE 3. Test circuit and switching waveforms.

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TABLE II. Electrical test requirements.

MIL-STD-883 test requirements	Subgroups (per method 5005, table I)
Interim electrical parameters (method 5004)	---
Final electrical test parameters (method 5004)	1*,2,3,7,8,9
Group A test requirements (method 5005)	1,2,3,7,8,9, 10,11
Groups C and D end-point electrical parameters (method 5005)	1,2,3

\* PDA applies to subgroup 1.

5. PACKAGING

5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-M-38510.

6. NOTES

6.1 Intended use. Microcircuits conforming to this drawing are intended for use when military specifications do not exist and qualified military devices that will perform the required function are not available for OEM application. When a military specification exists and the product covered by this drawing has been qualified for listing on QPL-38510, the device specified herein will be inactivated and will not be used for new design. The QPL-38510 product shall be the preferred item for all applications.

6.2 Replaceability. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.

6.3 Configuration control of SMD's. All proposed changes to existing SMD's will be coordinated with the users of record for the individual documents. This coordination will be accomplished in accordance with MIL-STD-481 using DD Form 1693, Engineering Change Proposal (Short Form).

6.4 Record of users. Military and industrial users shall inform Defense Electronics Supply Center when a system application requires configuration control and the applicable SMD. DESC will maintain a record of users and this list will be used for coordination and distribution of changes to the drawings. Users of drawings covering microelectronics devices (FSC 5962) should contact DESC-ECC, telephone (513) 296-6022.

6.5 Comments. Comments on this drawing should be directed to DESC-ECC, Dayton, Ohio 45444, or telephone (513) 296-8525.

6.6 Approved sources of supply. Approved sources of supply are listed in MIL-BUL-103. The vendors listed in MIL-BUL-103 have agreed to this drawing and a certificate of compliance (see 3.6 herein) has been submitted to and accepted by DESC-ECC.

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